Customer 客戶名稱：　　No 序列號:

Attention 聯繫人：　　Approval Date 承認日期:

Your Part No 客戶料號：　　Sample No 樣品號.：

SPECIFICATION

規　格　說　明　書

Model 型號：　USB

Spec No 規格：　US B-A1D06F-4B4N-W

Customer Approval Status 客戶承認狀況	HUATAC File Publish Sign 華傑文件發行蓋章處
Dsg'd 設計:	Edition 版本：　A
Chk'd 審核:	
App'd 批准:	
File Publish Sign 文件發行蓋章處	File clerk 文管:

HUA JIE (TAIWAN) CORP.

臺灣華傑股份有限公司

6F,NO.25,JI-LIN ROAD.CHUNG LI.

TAIWAN (CHUNGLI INDUSTRILA ZONE)

臺灣中壢工業開發區吉林路 25 號 6 樓

E-mail:huajie@mail.hua-jie.com

SUZHOU HUAJIE ELECTRONICS CO.LTD

蘇州華傑電子有限公司

NO.7.Zhangzhuang Road Huangqiao

Town Suzhou.China

中國江蘇省蘇州市黃橋鎮張莊路 7 號

技术部 11.03.22 卢红

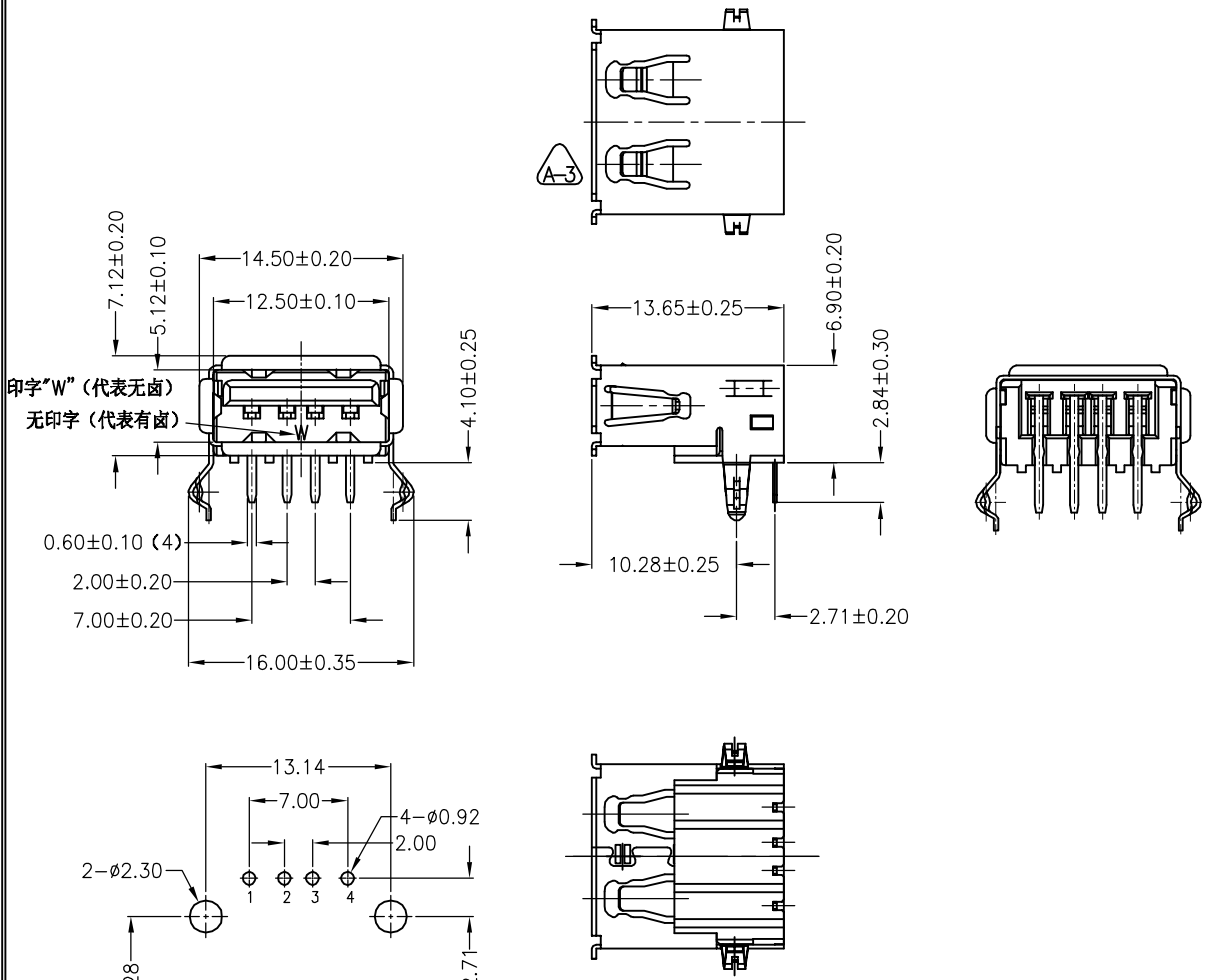
Dsg'd 設計

技术部 11.03.22 陈志方

App'd 批准

Sales 業務員

REV	DESCRIPTION	DATE	ECN NO.	CHANGER
A/1	Modify w logo place	11.05.04	2011095	Sally
A/2	CHANGE PCB LAYOUT	12.11.23	2012221	SALLY
A-3	change shell	14-08-27	20140620122	lhp.liu



RECOMMENDED P.C.B HOLE LAYOUT
TOP VIEW(TOLERANCE:iÀ0.10)

Specification
1.Current Rating:1.5AMP at 250V AC
Voltage Rating:30V
2.Insulation Resistance:1000M¦¸ Min
3.Contact Resistance:30m¦¸ Max
4.Dielectric Withstanding Voltage:500V AC
5.Temperature Range:-20°C to +85°C
Remark:48Hours Guarantee by -30°c storage temperaturee
6.Mechanical Characteristics:
Insertion Force:35 Newtons maximum
Extraction Force:10 Newtons minimum

P/N NOTE:
USB-A1D06F-XX4X-X
- W=without halogen O=UL94-V0
- Shell plate spec: T=Tin plated, N=Nickel plated
- Housing colour: B=Black, N=Nature, W=White
- Contact plate spec: 0=FU", 1=3U", 2=6U", 3=15U", 4=30U"

NO.	VARIETY	MATERIAL	QT,Y	REMARK
3	Shell	C2680H	1	T=0.30 Plating nickel/Tin
2	Housing	P.B.T	1	UL94V-0 Nature/Black/White
1	Contact	C2680EH	4	T=0.25 Plating Gold

SUZHOU HUAJIE ELECTRONICS CO.,LTD

X. ±0.38	X.iã±4°	UNIT:	mm	DR:	SALLY	TITLE:	USB A TYPE(FEMALE) DIP 90° L=13.65		
.X ±0.25	.Xiã±2°	3RD:		DE:	JACK				
.XX±0.20	.XXiã	SCALE:	1:1	CHKD:		SHEET:	1/1	P/N:	USB-A1D06F-XX4X-X
.XXX±0.10	.XXXiã	REV:	A-3	APPD:		D/N:	1014-0006	M/N:	
CUSTOMER DRAWING									

PRODUCT SPECIFICATION		Rev.No.	A/0
Subject:	USB2.0 A&B TYPE RECEPTACLE	page	1 of 4

1. material

1.1: Housing: Minimum UL 94-V0 rated, thirty percent (30%) glass-filled polybutylene terephthalate (PBT) or better.
Thermal capability: SMT TYPE >260 oC; DIP TYPE >205 oC; solder TYPE > 350 oC of 5s

1.2: Shell: Substrate Material: 0.30 + 0.05 mm phosphor bronze, nickel silver, or other copper based high strength materials.
Plating: Outside: Optional. Minimum 2.00 micrometers (80 microinches) nickel. In addition,manufacturer may use a copper underplate beneath the nickel.

1.3: Terminal: Substrate Material: 0.25 + 0.05 mm minimum half-hard phosphor bronze or other high strength copper based material;
Plating: 1.3.1.Underplate: Minimum 1.25 micrometers (50 microinches) nickel. Copper over base material is optional.
1.3.2. Mating Area: Minimum 0.05 micrometers (2 microinches) gold.
1.3.3. Solder Tails: Minimum 3.8 micrometers (150 microinches) bright tin over the underplate.

2. Electrical Characteristics

2.1: All electrical characteristics must be measured at or referenced to +20 oC (68 oF).

2.2: Voltage Rating: 30 V rms maximum.

2.3: Contact Current Rating: 1.5 A at 250 V AC minimum. when measured at an ambient temperature of 25 ℃. With power applied to the contacts, the . T must not exceed +30 ℃ at any point in the USB connector under test.

3. Temperature Range:

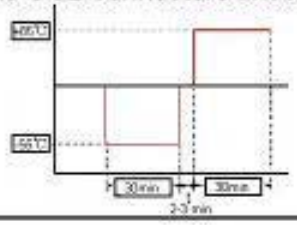
A. Operating Temperature Range: -55oC to +85oC

B. Storage Temperature Range: -20 oC to +60 oC

C. Nominal Temperature Rating: +20 oC

4. TEST Requirements and Procedures Summary

Item	Test Description	Test requirement	Test procedure
4.1	Insulation Resistance	1,000 MΩ, minimum.	EIA 364-21 Insulation Resistance The object of this test procedure is to detail a standard method to assess the insulation resistance of USB connectors. This test procedure is used to determine the resistance offered by the insulation materials and the various seals of a connector to a DC potential tending to produce a leakage of current through or on the surface of these members.
4.2	Dielectric Withstanding Voltage	The dielectric must Withstand500V AC for one minute at sea level.	EIA 364-20 The object of this test procedure is to detail a test method to prove that a USB connector can operate safely at its rated voltage and withstand momentary over-potentials due to switching,surges, and/or other similar phenomena.
4.3	Low Level Contact Resistance	30mΩ, maximum When measured at 20 mV maximum open circuit at 100 mA. Mated test contacts must be in a connector housing.	EIA 364-23 The object of this test is to detail a standard method to measure the electrical resistance across a pair of mated contacts such that the insulating films, if present, will not be broken or asperity melting will not occur.

4.4	Contact Current Rating	1.5 A at 250 V AC minimum when measured at an ambient temperature of 25 ℃. With power applied to the contacts, the . T must not exceed +30 ℃ at any point in the USB connector under test.	EIA 364-70 — Method B The object of this test procedure is to detail a standard method to assess the current carrying capacity of mated USB connector contacts.
4.5	Contact Capacitance	2 pF maximum unmated per contact.	EIA 364-30 The object of this test is to detail a standard method to determine the capacitance between conductive elements of a USB connector.
4.6	Insertion Force	35 Newtons maximum at amaximum rate of 12.5 mm(0.492") per minute.	EIA 364-13 The object of this test is to detail a standard method for determining the mechanical forces required for inserting a USB connector.
4.7	Extraction Force	10 Newtons minimum at a maximum rate of 12.5 mm(0.492") per minute.	EIA 364-13 The object of this test is to detail a standard method for determining the mechanical forces required for extracting a USB connector.
4.8	Durability	1,500 insertion/extraction cycles at a maximum rate of 200 cycles per hour. (Insertion force : 35N(3.57kgf) maximum Withdraw force : 10N minimum. 35N maximum.)	EIA 364-09 The object of this test procedure is to detail a uniform test method for determining the effects caused by subjecting a USB connector to the conditioning action of insertion and extraction, simulating the expected life of the connectors. Durability cycling with a gauge is intended only to produce mechanical stress. Durability performed with mating components is intended to produce both mechanical and wear stress.
4.9	Random Vibration	No discontinuities of 1 ∫s or longer duration when mated USB connectors are subjected to 5.35 Gs RMS. 15 minutes in each of three mutually perpendicular planes.	EIA 364-28 Test Condition V Test Letter A This test procedure is applicable to USB connectors that may, in service, be subjected to conditions involving vibration. Whether a USB connector has to function during vibration or merely to survive conditions of vibration should be clearly stated by the detailed product specification. In either case, the relevant specification should always prescribe the acceptable performance tolerances.
4.10	Thermal Shock	10 cycles –55 °C and +85 °C. The USB connectors under test 	EIA 364-32 Test Condition I The object of this test is to determine the resistance of a USB connector to exposure at extremes of high and low temperatures and to the shock of alternate exposures to these extremes, simulating the worst case conditions for storage, transportation, and application.

PRODUCT SPECIFICATION		Rev.No.	A/0
Subject:	USB 2.0 A&B TYPE RECEPTACLE	page	3 of 4

4.11	Humidity Life	168 hours minimum (seven complete cycles).The USB connectors under test must be tested in accordance with EIA 364-31 . Temperature: [+40°c] Relative Humidity: 80% to 95% Duration : 168 hours	EIA 364-31 Test Condition A Method III The object of this test procedure is to detail a standard test method for the evaluation of the properties of materials used in USB connectors as they are influenced by the effects of high humidity and heat.
4.12	Solderability	USB contact soleer tails must pass 95% coverage after one hour steam aging as specified in Category 2 . Soldering time:3 +/-0.5 Sec, Solder temperature:235+/-5℃ Max,1 mm from Terminal tip and fitting nail tip	EIA 364-52 The object of this test procedure is To detail a uniform test method for determining USB connector solderability. The test procedure contained herein utilizes the solder dip technique. It is not intended to test or evaluate solder cup, solder eyelet, other hand-soldered type, or SMT type terminations.
4.13	Flammability	The manufacturer will require its therm oplastic resin vendor to supply a detail C of C with each resin shipment . The C of C shall clearly the resin's UL listing nember ,lot number ,date code ,etc .	UL 94 V-0 This procedure is to ensure thermoplastic resin commpliance to UL flammability standards.
4.14	Thermal Aging	ANSI/EIA-364-17,Condition 3, Method A Mate connectors and expose to +85° ± 2°c,250hours. Upon completion of the exposure period, the test specimens shall be conditioned at ambient room conditions for 1 to 2 hours, after shich the specified measurements	Appearance:No physical damage Contact Resistance: Should meet spec. specified
4.15	Resistance to Soldering heat	By wave soldering:260+/-5C Soldering time: 10±1 Sec, By soldering iron: Solder Temperature: 390± 10 ℃.	Appearance: no damage Contact Resistance: Should meet spec. specified

5.Protocol Overhead	(Based on 480Mb/s and 8 bit interpacket gap, 88 bit min bus turnaround, 32 bit sync, 8 bit EOP: (3x4 SYNC bytes, 3 PID bytes, 2 EP/ADDR+CRC bytes, 2 CRC16 and a 3x(1+11) byte interpacket delay(EOP, etc.))				
Data	**Payload**	**Max**	**Bandwidth**	**(bytes/second)**	**Microframe**
1	1064000	1%	133	52	133
2	2096000	1%	131	33	262
4	4064000	1%	127	7	508
8	7616000	1%	119	3	952
16	13440000	1%	105	45	1680
32	22016000	1%	86	18	2752
64	32256000	2%	63	3	4032
128	40960000	2%	40	180	5120
256	49152000	4%	24	36	6144
512	53248000	8%	13	129	6656
1024	49152000	14%	6	1026	6144
2048	49152000	28%	3	1191	6144
3072	49152000	42%	2	1246	6144
MAX	60000000				7500

包装格式：


(P) Part NO: 2B. C0073. 031
(L) Lot No:
L00000000001506180001
(Q) Quantit: 3000
(E) Product date + Expire days :
(B) E20150618 0360
B2B. C0073. 03101364201506180300 0
(R) Reel ID:
R013642015061800001
Qisda

产品质量证明书

CERTIFICATE OF QUALITY

北京金鹰铜业有限责任公司
BeiJing Jin Ying Copper Products Co.,Ltd
Xiaojie Liyuan Tongzou Beijing China
TEL:086-01060526450-207 FAX:01060527336

客户名称 Customer	合同号 Contract No	重量(Kg) Weight(Kg)	签发日期 Date of Issue
东莞京温贸易公司	2006-004-06	2456.6	2006-04-12

牌号 Brand	标准 Standard No	规格 (mm) Dimension	批号 Lot No	状态 Temper	表面质量 Surface Quality
C2680	GB/T5231-2001	0.3X305	B-2408	H	OK

化学成份 Chemioal compositon

		Cu	Pb	Fe	Bi	P	Zn
标准	Min	63.5	/	/	/	0.1	/
Spec	Max	66.5	0.02	0.1	0.002	0.02	
实测	Acteal	64.5	0.01	0.03	/	0.011	余量

尺寸公差(mm) Size Tolerance

名称 name	厚度Thickness	宽度 Width	长度Length
标准 Spec	0.3±0.01	305±0.5	/
Min	0.29	304.5	/
Max	0.31	305.5	/

机械性能 Mechanism propertics

项目 Item		抗拉强度(kgf/mm2) Tensile Strength	延伸率 (%) Elongation	硬度 (HV) Hardness		
标准	MIN	/	13	140		
Spec	MAX	/	18	160		
实测 Actual		468	16	148		

质检部长 chief in quality:

检验员 inspecter:

北京金鹰铜业有限责任公司 产品质量专用章

2006 May 29 13:11 HP LASERJET FAX

产品质量证明书

CERTIFICATE OF QUALITY

东莞市金耀铜制品有限公司

Dongguan Jinyao Copper Products Co., Ltd.

Shabian Village, Xiabian Precinct, Chang'an Town, Dongguan City, Guangdong Province, China

TEL:0769-81608900 FAX:0769 81608901

客户名称 Customer	合同号 Contract No.	重量(Kg) Weight(Kg)	签发日期 Date of Issue
	2008-04-18	3256	2008-04-25

牌号 Brand	标准 Standard No.	规格 (mm) Dimension	状态 Temper	表面质量 Surface Quality
C2680	GB/T5231-2000	0.25X305	EH	OK

化学成份 Chemical compositon

		Cu	Pb	Fe	Bi	P	Zn
标准 Spec	Min	63.5	/	/	/	/	/
	Max	66.5	0.03	0.1	0.002	0.01	
实测	Acteal	64.17	0.01	0.029	/	0.006	余量

尺寸公差(mm) Size Tolerance

	厚度 Thickness	宽度 Width	长度 Length
标准 Spec	0.25+0.01	305+0.5	/
Min	0.24	304.5	/
Max	0.26	305.5	/

机械性能 Mechanism propertics

项目 Item		抗拉强度(kgf/mm2) Tensile Strength	延伸率 (%) Elongation	硬度 (HV) Hardness		
标准	Min	/	4	160		
Spec	Max	/	/	180		
实测	Actual	562	9	172		

注：本证明书请妥善保管，本产品经检验符合标准，所提供的数据均为测试值，如有质量异议，请于七天内提出，本公司将竭诚为您服务。

出证人 Issued By: 周玲

东莞市金耀铜制品有限公司 质检专用章

东莞博辉塑胶制品有限公司

材 质 证 明

PBT+30%GF V0　BK

PBT 树脂	51.5%
玻璃纤维	30%
阻燃剂	18%
黑　种	0.5%

注：含量完全符合国际无卤标准

东莞市博辉塑胶制品有限公司

物　性　表

PBT特性:本产品具有优良之耐化学性,耐候性,电器特性;
结晶快,易成型;耐热性较好等优点.

品名规格: PBT+30%GFV0 无卤 BK

性能 PROPERTY	测试方法 METHOD	单位 UNITS	标准 STANDARDS	参数 INDEX
玻璃含纤 PERCENT OF FIBRE-GALSS	燃烧法	%	30±2	30
比重 SPECIFIC GRAVITY	ASTMD-792	-	1.6±0.03	1.6
模收缩率 MOLD SHRINKAGE	ASTMD-955	%	0.28±0.1	0.28
热变形温度 HEAT DISTORTIONTEMPERATURE	ASTMD-648	℃	225±5	225
拉伸强度 TENSILE YIELD STRENGTH	ASTMD-638	kg/mm^2	9.5±0.5	9.4
含水率 WATER ABSORPTION	ASTMD	%	0.2±0.1	0.3
伸长率 ELONGATION AT BREAK	ASTMD-638	%	4.0±2	3.0
弯曲强度 FLEXURAL STRENGTH	ASTMD-790	kg/cm^2	13±1	13.8
冲击强度 IZOD IMPACT STREHGTH	ASTMD-256	kgcm/cm	5.0±1	5.3
燃烧性(1/8寸) FLAMMABILITY	U.L-94	-	V_0	V_0
洛氏硬度 ROCK WLL HARDNESS	ASTMD-785	R Scale	120±10	120
介电常数 DLELCTRIC CONSTANT	ASTMD-150	-	3.0±0.5	3.4
介电强度 DLELECTRIC STRENGTH	ASTMD-149	Kv/mm	20±5	23

本表数据仅供参考使用

No.	uinch Ni	uinch Cu	Ni 95.50 tolerance 110.63 125.76
1	108.94	165.71	
2	104.98	161.52	
3	108.17	123.98	
4	112.99	125.68	
5	118.07	121.02	
MEAN	110.63	139.58	
S.DEV	5.044	22.052	

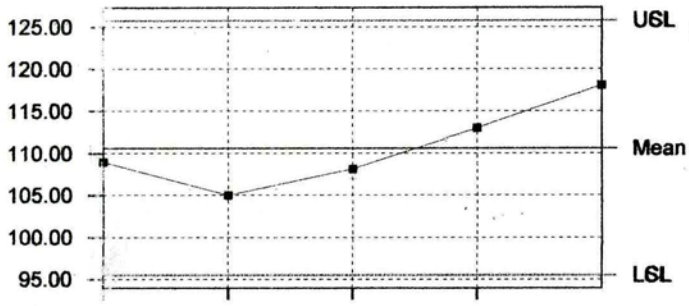
FUNC: MEASURE

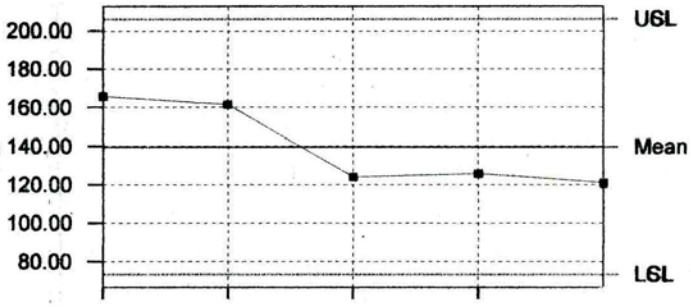
TIME: 00:08

COL : 0.20 mm

----- Ni -----
----- Cu -----
----- Fe -----

SEC: 5





Ni/Cu//Fe STATISTICAL RESULT

	Ni uinch	Cu uinch
Data No:	5	5
Maximum:	118.07	165.71
Minimum:	104.98	121.02
Range :	13.09	44.69
Mean :	110.63	139.58
Std.dev:	5.044	22.052
CV%:	4.559	15.799

恒鑫源五金制品厂 QA PASS

恒 鑫 源 五 金 制 品 厂

File:Cu(黄铜）-Ni(未储存)　　2011/ 1/20　16:36:43

测试仪器型号　SFT9200
客户/厂商　荣盛
品名规格　A母外壳
测试日期　1-20
批号　F11011913
测试编号　Q20110120023
测试员：沈文慧　审核：

1 Ni　95.05(μinch)

2 Ni　89.62(μinch)

3 Ni　107.51(μinch)

4 Ni　102.53(μinch)

5 Ni　95.05(μinch)

	平均值	标准误差	最大值	最小值
Ni	97.95	7.046	107.51	89.62

File:Cu(黄铜）-Ni-Au(FU)(未储存)　　2011/ 2/17　　9:22:06

测试仪器型号　　SFT9200
客户/厂商　　联益
品名规格　　A母端子FU
测试日前　　2-17
批号　　Y1102161303A
测试编号　　Q20110217002
测试员：沈文慧　审核：

1 Au　　1.44(μinch)
　Ni　　79.21(μinch)

2 Au　　1.53(μinch)
　Ni　　82.24(μinch)

3 Au　　1.82(μinch)
　Ni　　84.63(μinch)

4 Au　　1.54(μinch)
　Ni　　81.46(μinch)

5 Au　　1.70(μinch)
　Ni　　81.23(μinch)

6 Au　　1.76(μinch)
　Ni　　82.94(μinch)

	平均值	标准误差	最大值	最小值
Au	1.63	0.150	1.82	1.44
Ni	81.95	1.817	84.63	79.21

测 试 报 告
Inspection Report

测试单位：品管部　　试验项目： 盐雾测试　　测试日期： 2011-3

Test Dept: QC　　Test Item: Spray test　　Test Date:

样 品 来 源 Product Origin	工程部	规 格 Specification	镀镍
品 名 Item	USB-A 母产品	材 质 Material	黄铜
产品要求 Product Demand	外观良好，无发绿、氧化现象。 Nicer appearance, without Getting green and oxidation	测试依据 Test standard	CNS-4158
进料批号	A101101002	进料数量	200PCS

测 试 条 件	Test Condition	实际值 Actual value
氯化钠品质 NaCl	不纯物小于 0.3%	0.1%
实验室温度 Test temperature	35℃±1℃	35℃
压力桶温度 Pressure barrel temperature	47℃±1℃	47℃
喷雾时间 Spray Time	18~48H	18H
PH 值 PH Value	6.5-----7.2	6.8
蒸馏水品质 Distilled Water	纯水固体物小于 200PPM	<200ppm
实验湿度 Test Humidity	大于 85%RH	94%RH
喷雾周期 Spray periods	连续喷雾	连续喷雾
溶液浓度 Liquid concentration	5%	5%
压缩空气压力 Compressed air pressure	1.00±0.01Kgf/cm2	1.00Kgf/cm2
喷雾量 Spray Amount	1--2Ml/80cm2/h	1.5Ml/80cm2/h

测试仪器名称 Equipment name	盐水喷雾试验箱 Salt spray Tester	型号 Model	ZY6021

测试结果 Result / 序号 NO.	测试结果 Result
1	外观表面良好，无生锈、氧化现象。
2	外观表面良好，无生锈、氧化现象。
3	外观表面良好，无生锈、氧化现象。
4	外观表面良好，无生锈、氧化现象。
5	外观表面良好，无生锈、氧化现象。
判定方法 Judgment method	在充足光源下;相距30cm前後左右各看3秒鐘目視確認，外观表面良好，无生锈、氧化现象。 On the condition of enough light, staring at the shield from 30cm height 3 secondary from front, back, left and right, Surface Nicer, without patina oxidation phenomenon
综合判定 Total rustle	合格 PASS

审核 Checker	荀云	测试者 Inspector	周承润	报告编号：Q20110304001

测 试 报 告
TEST REPORT

品名 P/N： USB-A母DIP90度　　报告编号(report NO)： Q201103022001

测试项目 Test item		测试条件 Test condition	测试要求 Test requirement	测试结果 Test result									
				1	2	3	4	5	6	7	8	9	10
电气特性 ELECTRICAL	接触电阻 Contact Resistance	在27℃，相对湿度85±5%的环境中，插头与插座之间的接触电阻。 Mate applicable plug and expose to 27℃,relative humidity 80±5%.	30m Ω 最大 30m Ω MAX	14.17	14.00	14.40	14.85	14.06	14.02	14.11	14.21	14.44	14.01
	绝缘电阻 Insulation Resistance	正常温度下，在相邻金针之间加上500V DC1分钟 Apply 500V DC for 1 minute between adjacent terminal	1000M Ω 最小 1000M Ω MIN	OK	OK	OK	OK	OK	OK	OK	OK	OK	OK
	耐压测试 Withstand Voltage	正常温度下，在相邻金针之间加上500V AC1分钟 Apply 500V AC for 1 minute between adjacent terminal	无击穿及飞弧现象 NO breakdown	OK	OK	OK	OK	OK	OK	OK	OK	OK	OK
机械测试 MECHANICAL	插入力 Insert Force	将与之相配合的插头以每分钟12.5mm的速度插入插座 Insert applicable plug at a rate of 12.5mm/M	3.57KGF 最大 3.57KGF MAX	1.14	1.13	1.14	1.13	1.13	1.12	1.13	1.13	1.13	1.13
	拔出力 Retention Force	将插头从插座中以每分钟12.5mm的速度拔出 Pull out applicable plug at a rate of 12.5mm/M	1.02KGF 最小 1.02KGF MIN	1.64	1.69	1.75	1.81	1.91	1.92	1.85	1.77	1.80	1.74
	机械寿命 Durability	将插头以每小时500个周期的速度插入插座再拔出,反复插拔1500次 When rated up of 1500cycles repeated at a rate of 500cycles/H	外观,弹性良好 Appearance be OK	OK	OK	OK	OK	OK	OK	OK	OK	OK	OK
			接触电阻小于30m Ω Contact resistance 30m Ω MAX	17.38	18.60	15.61	18.42	17.69	18.02	18.11	18.25	17.66	17.92
			插入力小于3.57KGF Insert Force 3.57KGF MAX	1.95	2.01	1.95	1.92	1.95	1.90	1.94	1.91	1.96	1.93
			拔出力大于1.02KGF Retention Force 1.02KGF MIN	2.08	2.08	2.08	2.07	2.07	2.05	2.05	2.04	2.03	2.00
判定（Sentence）				OK	OK	OK	OK	OK	OK	OK	OK	OK	OK

审核（checker）：数华　　测试（tester）： 周承润　　日期（date）： 2011-3-22

Underwriters Laboratories Inc.®

ECBT2.E253995

Connectors for Use in Data, Signal, Control and Power Applications

See General Information for Connectors for Use in Data, Signal, Control and Power Applications

WENZHOU YIHUA COMMUNICATION CONNECTOR CO LTD E253995
HOU XI INDUSTRY PARK
WENG YANG TOWN
YUEQING, ZHEJIANG 325606 CHINA

Low voltage connectors, Cat. Nos. USB-A1DXF, USB-A1DXM, USB-A1MXF, USB-A1SXF, USB-A1SXM, USB-A2DXF, USB-A2SXF, USB-B1DXF, USB-B1SXM, IEE-P1SXF, IEE-P1SXM, MIN-A1MXF, MIN-B1MXF, IEE-A1MXF, USB-A1MXM, MIN-A1SXM, MIN-B1SXM, IEE-P1DXF, IEE-H1MXF, IEE-A1DXF, IEE-A1SXF and IEE-A1SXM.

Marking: Company name and catalog designation on device or carton.

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View Test Results

View Test Results

View the test results for this product. Click 'Done' to exit.

Marketing Name	USB A RECEPTACLE SINGLE DECK / USB-A1D05F
Revision	3
TID	60001218
Category	Development > Cable Assemblies & Connectors > Hi-Speed > Receptacle A
Company	WENZHOU YIHUA COMMUNICATED CONNECTOR CO., LTD.

Test Details

Test Panel	Cable and Connectors
Test Lab	Electronics Testing Center, Taiwan
Certified Test Admins	Users certified by USB to administer tests at this lab: Lin, Andrew (aylin@etc.org.tw) Liu, Sophia (scl@etc.org.tw)

Test Suites

Displaying all 8 results.

Test Suite Name	Result	Attachment
Group 1	Pass	1218-G1.txt
Group 2	Pass	1218-G2.txt
Group 3	Pass	1218-G3.txt
Group 4	Pass	1218-G4.txt
Group 5	Pass	1218-G5.txt
Group 6	Pass	1218-G6.txt
Group 7	Pass	1218-G7.txt
Group 8	Pass	1218-G8.txt

Product State	Global Pass